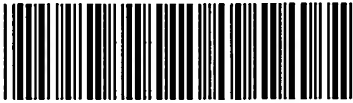


Search Notes

Application/Control No.

10/743,906

Examiner

Andrew Q. Tran

Applicant(s)/Patent under
Reexamination

OGIWARA ET AL.

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	149	1/16/2006	AT
	145		
	190		
	189.07		
	202		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
365	All above	1/16/2006	AT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST / BRS	1/16/2006	AT
IEEE Xplore	1/14/2006	AT